Silicon P Channel Power MOS FET High Speed Power Switching

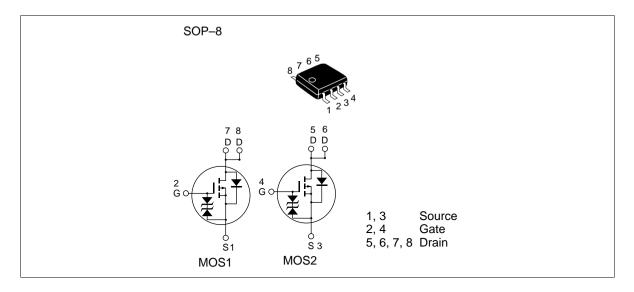
HITACHI

ADE-208-476 G (Z) 8th. Edition June 1997

Features

- Low on-resistance
- Capable of 4 V gate drive
- Low drive current
- High density mounting

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V _{DSS}	-30	V	
Gate to source voltage	V _{GSS}	±20	V	
Drain current	I _D	-3.5	А	
Drain peak current	Note1 D(pulse)	-28	А	
Body-drain diode reverse drain current	I _{DR}	-3.5	А	
Channel dissipation	Pch Note2	2	W	
Channel dissipation	Pch Note3	3	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Note: 1. $PW \le 10\mu s$, duty cycle $\le 1 \%$

2. 1 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW≤ 10s

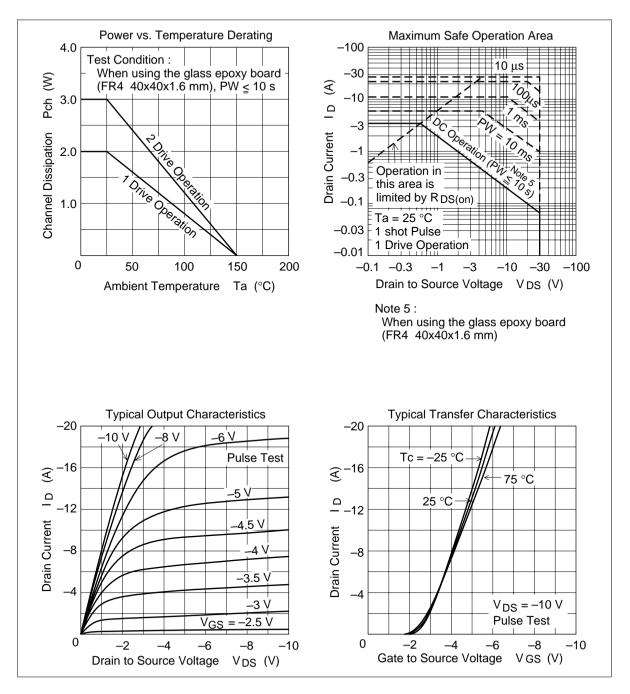
3. 2 Drive operation : When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW≤ 10s

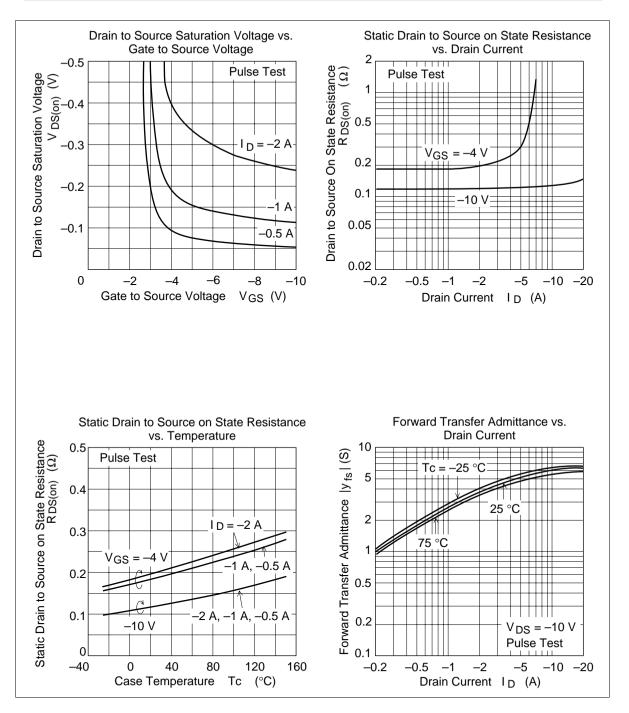
Electrical Characteristics (Ta = 25°C)

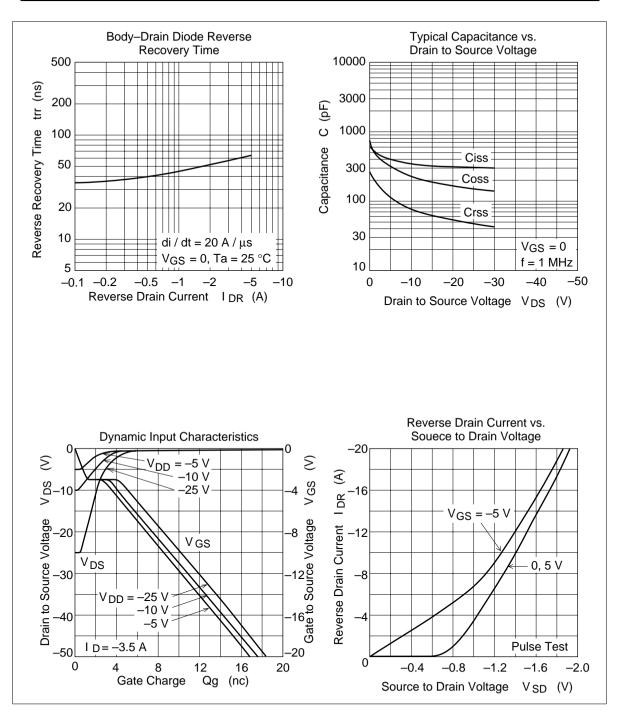
Drain to source breakdown voltage Gate to source breakdown voltage Gate to source leak current	V _{(BR)DSS} V _{(BR)GSS}	-30 ±20	—	_	V	$I_{\rm D} = -10$ mA, $V_{\rm GS} = 0$
voltage	$V_{(BR)GSS}$	+20				
Gate to source leak current		± 2 0	—	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
	I _{GSS}	_	_	±10	μA	$V_{GS} = \pm 16V, V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}			-10	μA	$V_{\rm DS} = -30$ V, $V_{\rm GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0		-2.5	V	$V_{DS} = -10V, I_{D} = -1mA$
Static drain to source on state	$R_{DS(on)}$		0.12	0.16	Ω	$I_{\rm D} = -2A, V_{\rm GS} = -10V^{\rm Note4}$
resistance	$R_{DS(on)}$		0.2	0.34	Ω	$I_{\rm D} = -2A, V_{\rm GS} = -4V^{\rm Note4}$
Forward transfer admittance	y _{fs}	2.5	3.5	—	S	$I_{\rm D} = -2A, V_{\rm DS} = -10V^{\rm Note4}$
Input capacitance	Ciss	_	350	_	pF	$V_{DS} = -10V$
Output capacitance	Coss		230	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss		75	_	pF	f = 1MHz
Turn-on delay time	t _{d(on)}		18	—	ns	$V_{GS} = -4V$, $I_D = -2A$
Rise time	t,		110	_	ns	$V_{DD} \cong -10V$
Turn-off delay time	$t_{d(off)}$		20	—	ns	—
Fall time	t _f	—	30	_	ns	_
Body–drain diode forward voltage	V_{DF}	—	-1.0	-1.5	V	$IF = -3.5A, V_{GS} = 0^{Note4}$
Body–drain diode reverse recovery time	t _{rr}	—	60	—	ns	IF = $-3.5A$, V _{GS} = 0 diF/ dt =20A/µs

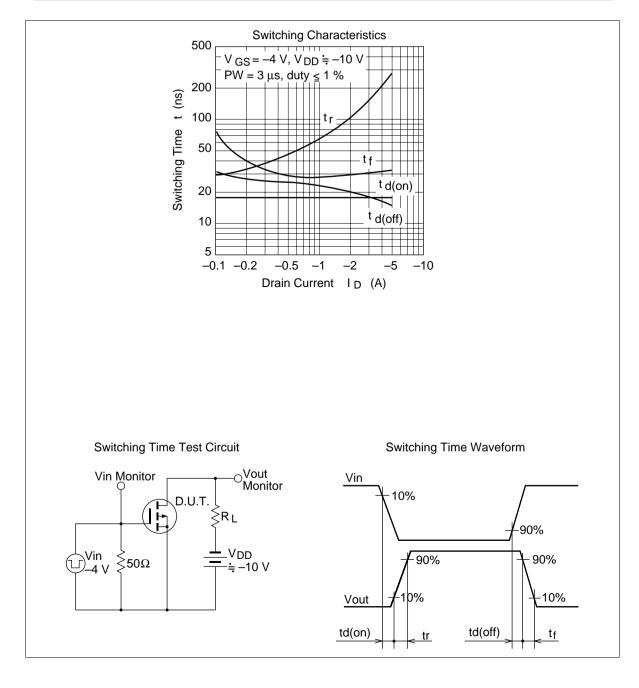
Note: 4. Pulse test

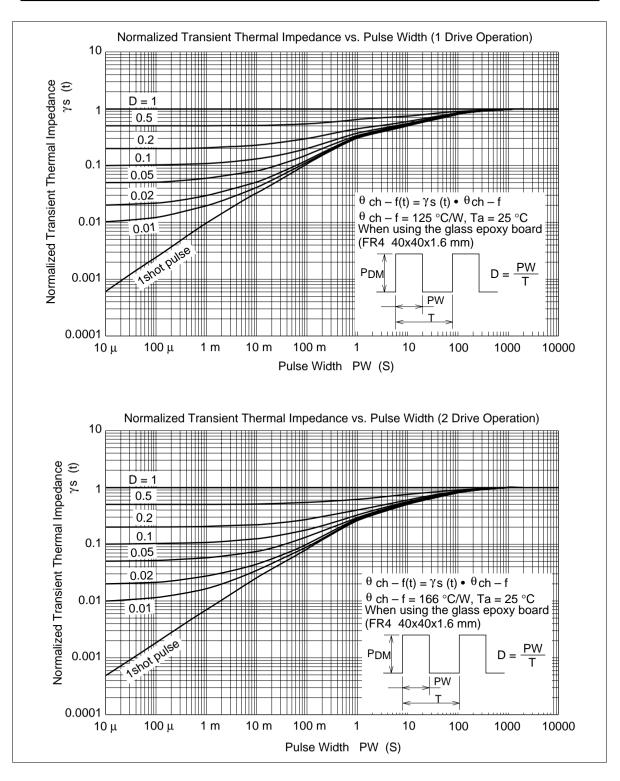
Main Characteristics



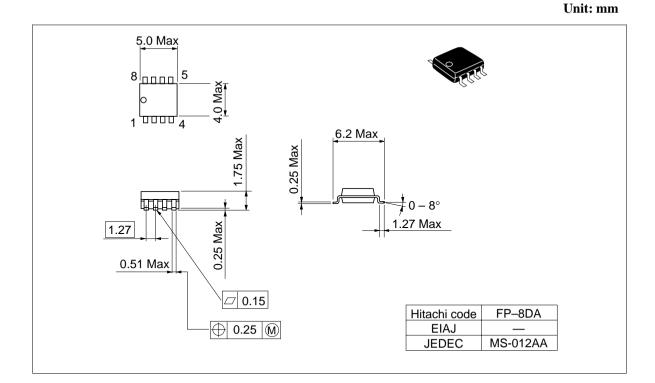








Package Dimentions



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Semiconductor & IC Div. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109 NorthAmerica URL http:semiconductor.hitachi.com/ http://www.hitachi-eu.com/hel/ecg Europe http://www.has.hitachi.com.sg/grp3/sicd/index.htm http://www.hitachi.com.tw/E/Product/SICD_Frame.htm Asia (Singapore) Asia (Taiwan) Asia (HongKong) http://www.hitachi.com.hk/eng/bo/grp3/index.htm Japan http://www.hitachi.co.jp/Sicd/indx.htm For further information write to: Hitachi Semiconductor Hitachi Europe GmbH Hitachi Asia Pte, Ltd. (America) Inc. Electronic components Group 16 Collyer Quay #20-00 2000 Sierra Point Parkway Dornacher Straße 3 Hitachi Tower Brisbane, CA 94005-1897 D-85622 Feldkirchen, Munich Singapore 049318 Tel: <1> (800) 285-1601 Germany Tel: 535-2100 Fax: <1> (303) 297-0447 Tel: <49> (89) 9 9180-0 Fax: 535-1533 Fax: <49> (89) 9 29 30 00 Hitachi Asia Ltd. Hitachi Europe Ltd. Taipei Branch Office Electronic Components Group. 3F, Hung Kuo Building. No.167, Whitebrook Park Tun-Hwa North Road, Taipei (105) Lower Cookham Road Tel: <886> (2) 2718-3666 Maidenhead Berkshire SL6 8YA, United Kingdom Fax: <886> (2) 2718-8180 Tel: <44> (1628) 585000 Fax: <44> (1628) 778322

Hitachi Asia (Hong Kong) Ltd. Group III (Electronic Components) 7/F., North Tower, World Finance Centre, Harbour City, Canton Road, Tsim Sha Tsui, Kowloon, Hong Kong Tel: <852> (2) 735 9218 Fax: <852> (2) 730 0281 Telex: 40815 HITEC HX

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